

Notice of References Cited	Application/Control No. 10/624,627		Applicant(s)/Patent Under Reexamination TRAN, LUAN C.	
	Examiner Scott Geyer		Art Unit 2812	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,518,113	02-2003	Buynoski, Matthew S.	438/217
	B	US-			
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	F	US-			
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	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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